

1、Description

Glass passivated high commutation triacs in a full pack, plastic envelope intended for use in circuits where high static and dynamic dV/dt and high di/dt can occur. These devices will commutate the full rated rms current at the maximum rated junction temperature, without the aid of a snubber.

2、Applications

Typical applications include motor control, industrial and domestic lighting, heating and static switching.

- Heating regulation
- Motor control
- Phase control

3、Features

- Blocking voltage to 800V
- On-state RMS current to 16A
- Ultra low gate trigger current
- Low cost package.

4、Pinning information

PIN	Description	Simplified outline	Symbol
1	main terminal 1 (T1)	 TO-220	
2	main terminal 2 (T2)		
3	gate (G)		

5、Quick reference data

SYMBOL	PARAMETER	MAX	UNIT
V_{DRM} V_{RRM}	Repetitive peak off-state voltages	800	V
$I_{T(RMS)}$	RMS on-state current	16	A
I_{TSM}	Non-repetitive peak on-state current	120	A

6、Thermal characteristics

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
$R_{th j-mb}$	Thermal resistance junction to mounting base	full cycle	-	-	1.5	K/W
		half cycle	-	-	2.0	K/W
$R_{th j-a}$	Thermal resistance junction to ambient	in free air		60	-	K/W

7. Limiting value

Limiting values in accordance with the Maximum System(IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN	MAX	UNIT
I_{TRMS}	RMS on-state current	full sine wave; $T_{mb} \leq 102^\circ C$	-	16	A
	Non-repetitive peak on-state current	full sine wave; $T_j = 25^\circ C$ prior to surge	$t = 20 \text{ ms}$ $t = 16.7 \text{ ms}$	- -	120 140 A
I^2t	I^2t for fusing	$t = 10 \text{ ms}$	-	45	A^2s
dI_T/dt	Repetitive rate of rise of on-state current after triggering	$I_{TM} = 16 \text{ A}; IG = 0.2 \text{ A};$ $DI_G/dt = 0.2 \text{ A/s}$	$T2+ G+$ $T2- G-$	-	100 $\text{A}/\mu\text{s}$
				-	100 $\text{A}/\mu\text{s}$
I_{GM}	Peak gate current		-	2	A
V_{GM}	Peak gate voltage		-	8	V
P_{GM}	Peak gate power		-	16	W
$P_{G(AV)}$	Average gate power	over any 20 ms period	-	0.35	W
T_{stg}	Storage temperature		-40	150	$^\circ C$
T_j	Junction temperature		-40	125	$^\circ C$

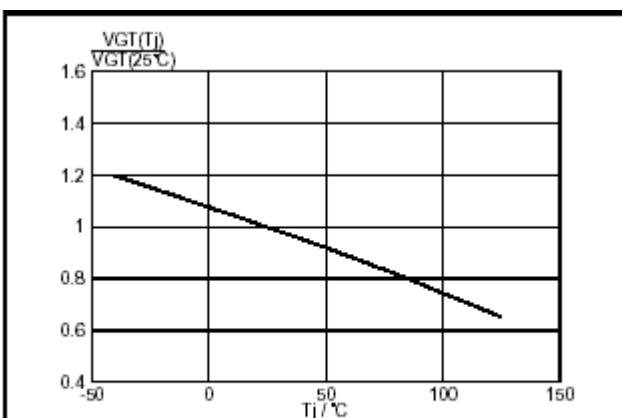
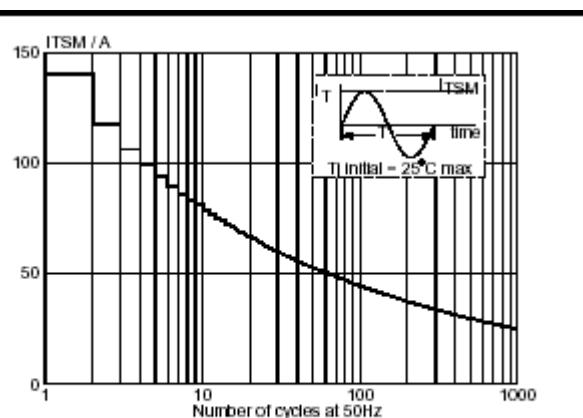
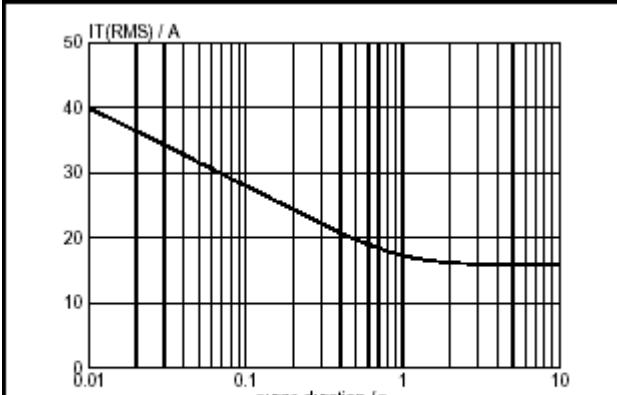
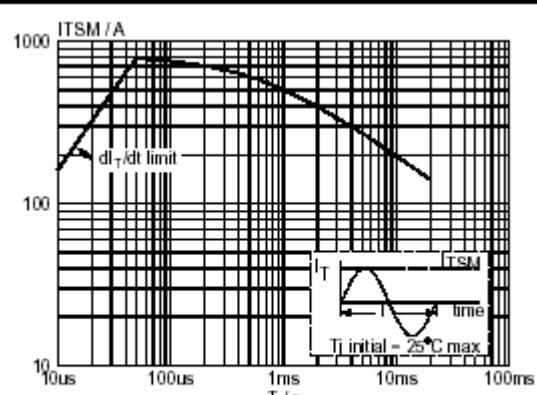
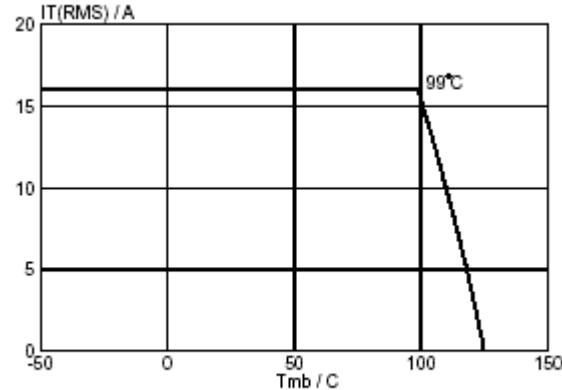
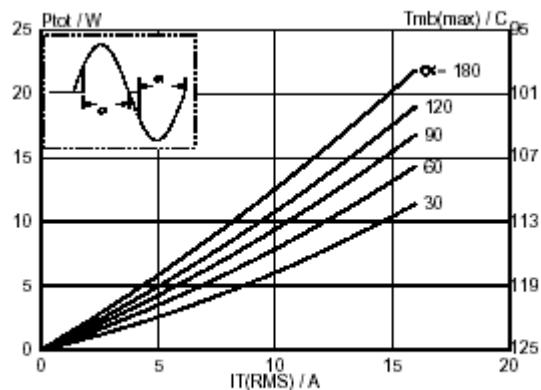
8. Characteristics

$T_j = 25^\circ C$ unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
Static characteristics						
I_{GT}	Gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}$	$T2+ G+$ $T2+ G-$ $T2- G-$	10	35	mA
				15	35	mA
				15	35	mA
I_L	Latching current	$V_D = 12 \text{ V}; I_{GT} = 0.1 \text{ A}$	$T2+ G+$ $T2+ G-$ $T2- G-$	-	20	50 mA
				-	30	80 mA
				-	20	50 mA
I_H	Holding current	$V_D = 12 \text{ V}; I_{GT} = 0.15 \text{ A}$		-	20	40 mA
V_T	On-state voltage	$I_T = 20 \text{ A}$		-	-	1.85 V
V_{GT}	Gate trigger voltage	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}$	$T2+ G+$ $T2+ G-$ $T2- G-$	0.5	0.78	1.5 V
				0.5	0.70	1.5 V
				0.5	0.71	1.5 V
Dynamic Characteristics						
dV_D/dt	Critical rate of rise of off-state voltage	$V_{DM} = 67\% V_{DRM(max)}; T_j = 125^\circ C;$ Exponential wave form; gate open circuit	250	500	-	$\text{V}/\mu\text{s}$
di_{com}/dt	Critical rate of change of commutating current	$V_D = 400 \text{ V}; T_j = 125^\circ C$ $I_{TRMS}=4.4 \text{ A}$; Commutating $dv/dt = 18 \text{ V}/\text{s}$, Without snubber; gate open circuit	6.5	-	-	A/ms
di/dt	Repetitive Critical Rate of Rise of On-State Current	$I_{PK} = 50 \text{ A}; PW = 40 \text{ sec}; di_G/dt = 200 \text{ mA}/\text{sec}$; $f = 60 \text{ Hz}$	-	-	10	$\text{A}/\mu\text{s}$

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9、Electrical Characteristics Curve



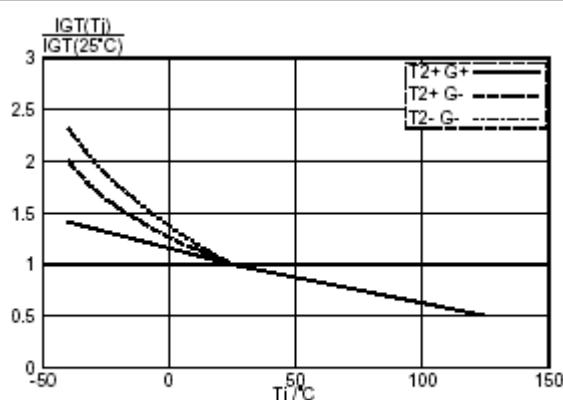


Fig. 7. Normalised gate trigger current $I_{GT}(T_j)/I_{GT}(25^\circ\text{C})$, versus junction temperature T_j .

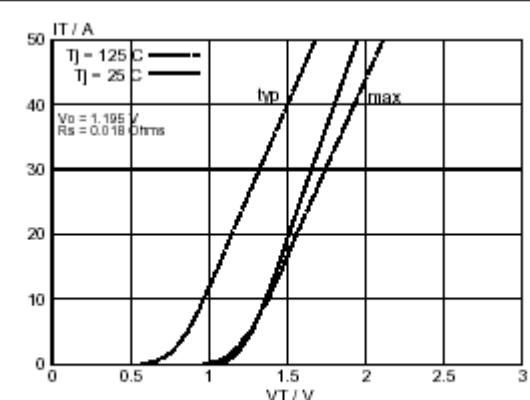


Fig. 10. Typical and maximum on-state characteristic.

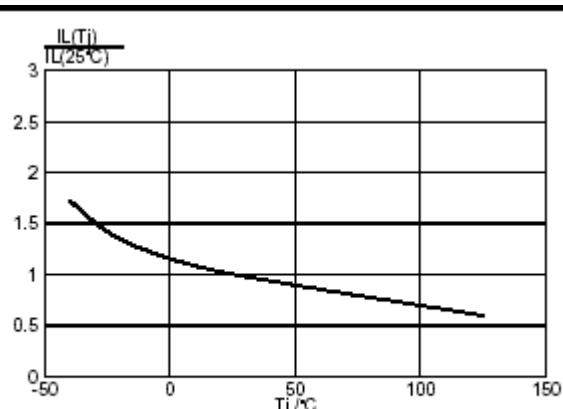


Fig. 8. Normalised latching current $I_L(T_j)/I_L(25^\circ\text{C})$, versus junction temperature T_j .

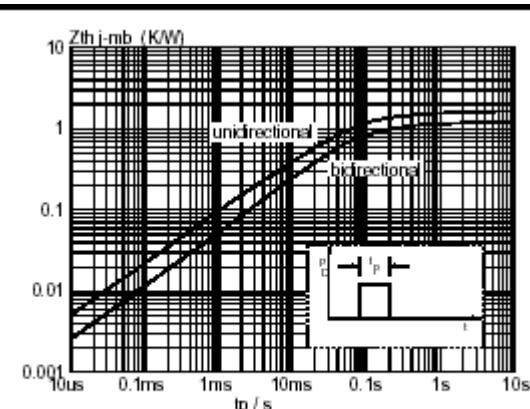


Fig. 11. Transient thermal impedance $Z_{th,j,mb}$ versus pulse width t_p .

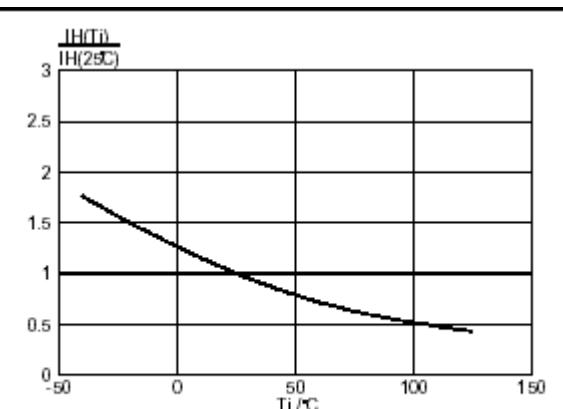


Fig. 9. Normalised holding current $I_H(T_j)/I_H(25^\circ\text{C})$, versus junction temperature T_j .

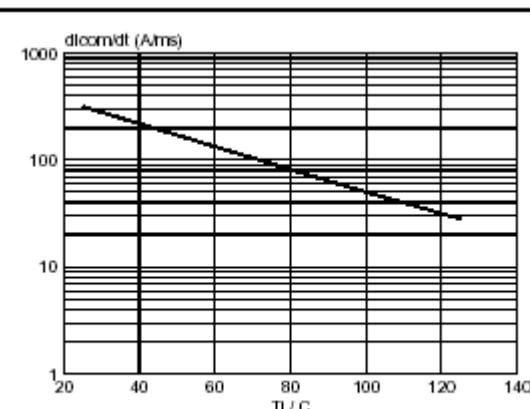
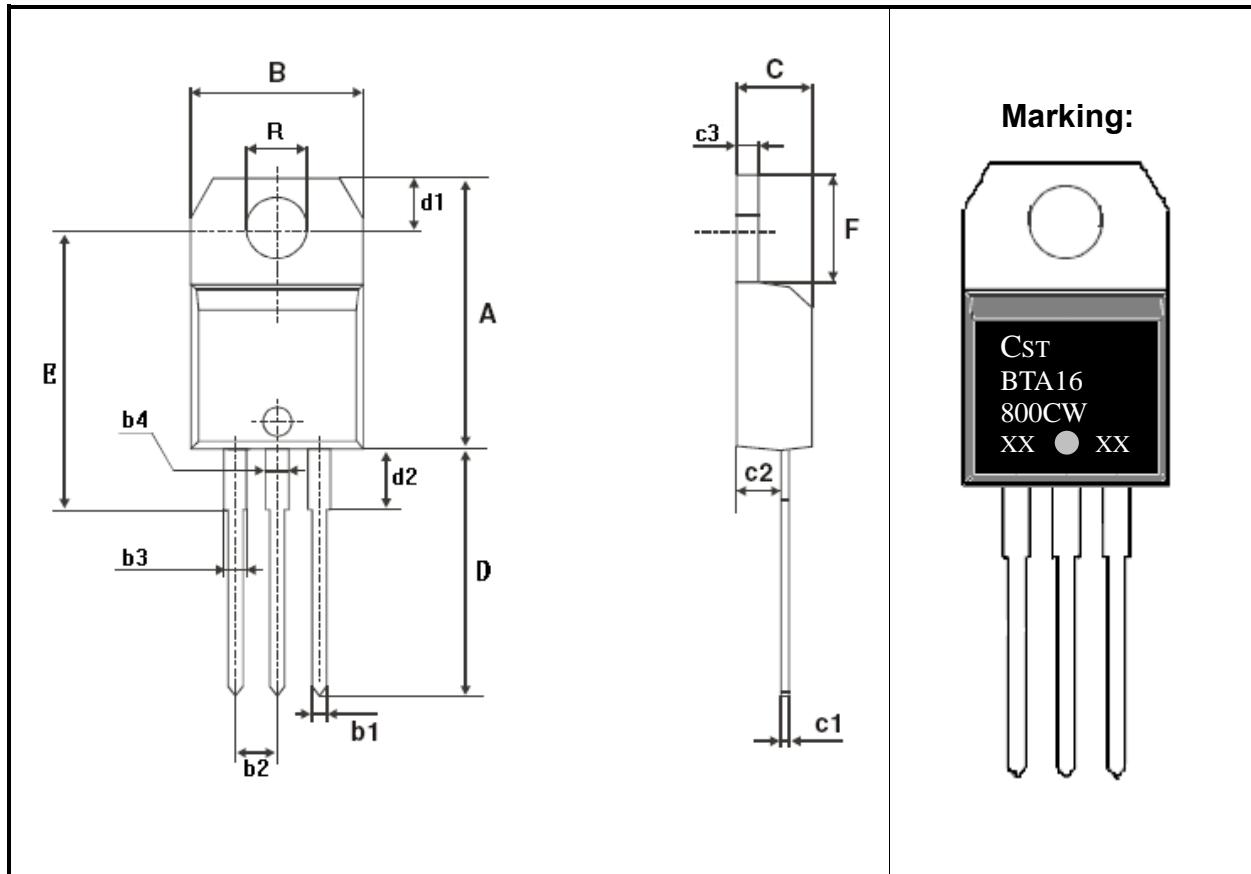


Fig. 12. Typical, critical rate of change of commutating current dI_{com}/dt versus junction temperature.

10、Package outline (TO-220I)



DIM	Inches			Millimeters		
	Min	Type	Max	Min	Type	Max
A	0.591	-	0.646	15.00	-	16.40
B	0.386	-	0.409	9.80	-	10.40
C	0.160	-	0.190	4.07	-	4.82
D	0.500	-	0.562	12.70	-	14.27
E	-	0.640	-	-	16.25	-
F	0.248	-	0.271	6.29	-	6.89
R	0.140	-	0.156	3.56	-	3.96
b1	0.030	-	0.037	0.75	-	0.95
b2	0.095	-	0.105	2.42	-	2.66
b3	0.046	-	0.054	1.17	-	1.37
b4	0.046	-	0.054	1.17	-	1.37
c1	0.017	-	0.023	0.42	-	0.58
c2	0.091	-	0.115	2.32	-	2.92
c3	0.045	-	0.055	1.15	-	1.39
d1	0.100	-	0.120	2.54	-	3.04
d2	0.125	-	0.155	3.18	-	3.93